

<b>Notice of References Cited</b>	Application/Control No. 10/659,226		Applicant(s)/Patent Under Reexamination TRAN ET AL.	
	Examiner David Lam		Art Unit 2827	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,657,913	12-2003	Abedifard et al.	365/230.03
	B	US-5,819,305	10-1998	Nixon, Matthew R.	711/100
	C	US-6,215,685	04-2001	Fung et al.	365/49
	D	US-6,657,899	12-2003	Roohparvar, Frankie F.	365/185.33
	E	US-6,381,190	04-2002	Shinkai, Eiji	365/230.03
	F	US-5,406,519	04-1995	Ha, Chang W.	365/195
	G	US-4,051,354	09-1977	Choate, William Clay	714/711
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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